

# T K Song

## List of Publications by Year in descending order

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docs citations

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times ranked

2471

citing authors

#	ARTICLE	IF	CITATIONS
1	Polarization Relaxation Induced by a Depolarization Field in Ultrathin Ferroelectric BaTiO <sub>3</sub> Capacitors. Physical Review Letters, 2005, 95, 237602.	7.8	305
2	Domain Switching Kinetics in Disordered Ferroelectric Thin Films. Physical Review Letters, 2007, 99, 267602.	7.8	234
3	Effects of Bi nonstoichiometry in (Bi <sub>0.5+x</sub> Na)TiO <sub>3</sub> ceramics. Applied Physics Letters, 2011, 98, .	3.3	192
4	Effects of Na nonstoichiometry in (Bi <sub>0.5</sub> Na <sub>0.5+x</sub> )TiO <sub>3</sub> ceramics. Applied Physics Letters, 2010, 96, .	3.3	169
5	Polarization switching kinetics of epitaxial Pb(Zr <sub>0.4</sub> Ti <sub>0.6</sub> )O <sub>3</sub> thin films. Applied Physics Letters, 2005, 86, 092905.	3.3	141
6	Leakage current mechanisms in lead-based thin-film ferroelectric capacitors. Physical Review B, 1999, 59, 16022-16027.	3.2	136
7	notRoles of lattice distortion in (1-x)(Bi <sub>0.5</sub> Na <sub>0.5</sub> )TiO <sub>3</sub> -xBaTiO <sub>3</sub> ceramics. Applied Physics Letters, 2010, 96, .	3.3	112
8	ac dynamics of ferroelectric domains from an investigation of the frequency dependence of hysteresis loops. Physical Review B, 2010, 82, .	3.2	96
9	Polarization Switching Dynamics Governed by the Thermodynamic Nucleation Process in Ultrathin Ferroelectric Films. Physical Review Letters, 2006, 97, 247602.	7.8	85
10	Structural and ferroelectric properties of the c-axis oriented SrBi <sub>2</sub> Ta <sub>2</sub> O <sub>9</sub> thin films deposited by the radiofrequency magnetron sputtering. Applied Physics Letters, 1996, 69, 3839-3841.	3.3	79
11	Coercive fields in ultrathin BaTiO <sub>3</sub> capacitors. Applied Physics Letters, 2006, 89, 232909.	3.3	61
12	Domain wall motion in epitaxial Pb(Zr,Ti)O <sub>3</sub> capacitors investigated by modified piezoresponse force microscopy. Applied Physics Letters, 2008, 92, .	3.3	59
13	Ferroelectric properties of SrRuO <sub>3</sub> -BaTiO <sub>3</sub> -SrRuO <sub>3</sub> ultrathin film capacitors free from passive layers. Applied Physics Letters, 2006, 88, 072909.	3.3	57
14	Evaluation of imprint in fully integrated (La,Sr)CoO <sub>3</sub> /Pb(Nb,Zr,Ti)O <sub>3</sub> /(La,Sr)CoO <sub>3</sub> ferroelectric capacitors. Journal of Applied Physics, 1998, 83, 2165-2171.	2.5	49
15	Controlled growth of a/b- and c-axis oriented epitaxial SrBi <sub>2</sub> Ta <sub>2</sub> O <sub>9</sub> ferroelectric thin films. Applied Physics Letters, 1999, 75, 2827-2829.	3.3	41
16	Mechanisms for retention loss in ferroelectric Pt/Pb(Zr <sub>0.4</sub> Ti <sub>0.6</sub> )O <sub>3</sub> /Pt capacitors. Applied Physics Letters, 2003, 82, 2124-2126.	3.3	41
17	Polarization dynamics and retention loss in fatigued PbZr <sub>0.4</sub> Ti <sub>0.6</sub> O <sub>3</sub> ferroelectric capacitors. Applied Physics Letters, 2003, 82, 248-250.	3.3	38
18	Piezoelectric and Dielectric Properties of Lead-Free (1-x)(Bi <sub>0.5</sub> K <sub>0.5</sub> )TiO <sub>3</sub> -xBiFeO <sub>3</sub> Ceramics. Ferroelectrics, 2010, 404, 88-92.	0.6	33

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19	Enhanced piezoelectric properties of $(Na_{0.5+y+z}K_{0.5-y})_x(Nb_{1-x}Ta_x)_yT_1$ ETQq1 1.0 784314 30	3.3	784314 30
20	Electric-field-controlled directional motion of ferroelectric domain walls in multiferroic BiFeO <sub>3</sub> films. Applied Physics Letters, 2009, 95, .	3.3	29
21	Ferroelectric and piezoelectric properties of Mn-modified BiFeO <sub>3</sub> -BaTiO <sub>3</sub> ceramics. Journal of Electroceramics, 2014, 33, 37-41.	2.0	24
22	Composition-dependent polarization switching behaviors of (111)-preferred polycrystalline Pb(ZrxTi1-x)O <sub>3</sub> thin films. Applied Physics Letters, 2008, 92, .	3.3	23
23	Enhanced piezoelectric properties of (Bi <sub>0.5</sub> K <sub>0.5+x</sub> Li <sub>y</sub> )TiO <sub>3</sub> ceramics by K nonstoichiometry and Li addition. Applied Physics Letters, 2009, 94, 062901.	3.3	22
24	Step bunching-induced vertical lattice mismatch and crystallographic tilt in vicinal BiFeO <sub>3</sub> (001) films. Applied Physics Letters, 2011, 98, .	3.3	22
25	Effects of sintering temperature on the electric properties of Mn-modified BiFeO <sub>3</sub> -BaTiO <sub>3</sub> bulk ceramics. Journal of the Korean Physical Society, 2015, 66, 1115-1119.	0.7	22
26	Structural, optical, and magnetic properties of single-crystalline Mn <sub>3</sub> O <sub>4</sub> nanowires. Journal of Nanoparticle Research, 2012, 14, 1.	1.9	17
27	Structural evolution of bismuth sodium titanate induced by a-site non-stoichiometry: Neutron powder diffraction studies. Journal of the Korean Physical Society, 2015, 67, 1583-1587.	0.7	17
28	Dielectric and Piezoelectric Properties of Nonstoichiometric SrBi <sub>2</sub> Ta <sub>2</sub> O <sub>9</sub> and SrBi <sub>2</sub> Nb <sub>2</sub> O <sub>9</sub> Ceramics. Journal of Electroceramics, 2004, 13, 515-518.	2.0	16
29	FERROELECTRIC SWITCHING DYNAMICS AND PULSE-SWITCHING POLARIZATION MEASUREMENTS. Integrated Ferroelectrics, 2006, 78, 191-197.	0.7	16
30	Enhancement of ferroelectricity in gadolinium (Gd) and transition metal (Ni, Co, Cr) Co-doped BiFeO <sub>3</sub> thin films via a chemical solution deposition technique. Journal of Electroceramics, 2013, 30, 13-18.	2.0	16
31	Ferroelectric and Piezoelectric Properties of BiFeO <sub>3</sub> -BaTiO <sub>3</sub> Solid Solution Ceramics. Ferroelectrics, 2013, 452, 7-12.	0.6	15
32	Enhanced piezoelectric properties of BaZrO <sub>3</sub> -substituted 0.67BiFeO <sub>3</sub> -0.33BaTiO <sub>3</sub> lead-free ceramics. Journal of the Korean Physical Society, 2015, 66, 1106-1109.	0.7	15
33	Ionic Doping Effects in SrBi <sub>2</sub> Nb <sub>2</sub> O <sub>9</sub> Ferroelectric Ceramics. Journal of Electroceramics, 2004, 13, 51-54.	2.0	14
34	Inhomogeneous domain nucleation and growth in disordered ferroelectric capacitors observed by modified piezoresponse force microscopy. Journal Physics D: Applied Physics, 2010, 43, 395403.	2.8	12
35	Influence of zirconium substitution on dielectric, ferroelectric and field-induced strain behaviors of lead-free 0.99[Bi <sub>1/2</sub> (Na <sub>0.82</sub> K <sub>0.18</sub> ) <sub>1/2</sub> (Ti <sub>1-x</sub> Zr <sub>x</sub> )O <sub>3</sub> ]-0.01Li <sub>2</sub> SiO <sub>3</sub> ceramics. Journal of the Korean Physical Society, 2012, 61, 773-778.	0.7	10
36	Piezoelectric and ferroelectric properties of textured (Na <sub>0.50</sub> K <sub>0.47</sub> Li <sub>0.03</sub> )(Nb <sub>0.8</sub> Ta <sub>0.2</sub> )O <sub>3</sub> ceramics by using template grain growth method. Journal of Electroceramics, 2013, 30, 72-76.	2.0	10

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37	Dielectric and Piezoelectric Properties of Lead-free BaTiO <sub>3</sub> -Bi(Zn <sub>0.5</sub> Ti <sub>0.5</sub> O <sub>3</sub> ) <sub>0.6</sub> Ceramics. <i>Ferroelectrics</i> , 2009, 380, 177-182.	0.6	9
38	Ferroelectric and leakage current behaviors of BiFeO <sub>3</sub> -Bi(Zn <sub>1/2</sub> Ti <sub>1/2</sub> O <sub>3</sub> ) ceramics. <i>Journal of Applied Physics</i> , 2009, 105, 061640.	2.5	8
39	Effect of oxygen pressure on electrical properties of Ge-doped ZnO thin films grown by using pulsed laser deposition. <i>Journal of the Korean Physical Society</i> , 2012, 61, 920-923.	0.7	8
40	Enhanced piezoelectric properties of lead-free 0.935(Bi <sub>0.5</sub> Na <sub>0.5</sub> )TiO <sub>3</sub> -0.065BaTiO <sub>3</sub> thin films fabricated by using pulsed laser deposition. <i>Journal of the Korean Physical Society</i> , 2013, 62, 1031-1034.	0.7	7
41	Mechanism of Charge Retention Loss in Ferroelectric Pt/Pb(Zr,Ti)O <sub>3</sub> /Pt Capacitors and Its Relation to Fatigue and Imprint. <i>Integrated Ferroelectrics</i> , 2003, 53, 401-411.	0.7	6
42	Leakage Current Behaviors of SrTiO <sub>3</sub> /BiFeO <sub>3</sub> Multi-Layers Fabricated by Pulsed Laser Deposition. <i>Integrated Ferroelectrics</i> , 2012, 134, 133-138.	0.7	6
43	Structural and electrical properties of polycrystalline Bi(Fe <sub>0.6</sub> Mn <sub>0.4</sub> )O <sub>3</sub> thin films. <i>Journal of the Korean Physical Society</i> , 2013, 63, 2325-2329.	0.7	6
44	EFFECT OF BiFeO <sub>3</sub> DOPING ON FERROELECTRIC AND PIEZOELECTRIC PROPERTIES OF (Bi <sub>0.5</sub> Na <sub>0.5</sub> )TiO <sub>3</sub> AND BaTiO <sub>3</sub> CERAMICS. <i>Integrated Ferroelectrics</i> , 2006, 84, 31-38.	0.7	5
45	FABRICATION AND ORIENTATION DEPENDENCE ON ELECTRICAL PROPERTIES OF Na <sub>0.5</sub> Bi <sub>4.5</sub> Ti <sub>4</sub> O <sub>15</sub> THIN FILMS. <i>Integrated Ferroelectrics</i> , 2009, 107, 112-120.	0.7	5
46	Electrical properties of thin films deposited with MnO- and MnO <sub>2</sub> -modified BiFeO <sub>3</sub> oxide targets. <i>Journal of the Korean Physical Society</i> , 2012, 61, 1070-1074.	0.7	5
47	Structure and Multiferroic Properties of V-doped Bi <sub>6</sub> Fe <sub>2</sub> Ti <sub>3</sub> O <sub>18</sub> Thin Films Prepared by Chemical Solution Deposition. <i>Ferroelectrics</i> , 2014, 465, 68-75.	0.6	5
48	Effects of K Nonstoichiometry in (Bi <sub>0.5</sub> K <sub>0.5+x</sub> )TiO <sub>3</sub> Ceramics. <i>Integrated Ferroelectrics</i> , 2010, 114, 92-99.	0.7	4
49	Effects of A-Site Nonstoichiometry on Dielectric and Piezoelectric Properties of Pb-Free (Na <sub>0.53+x</sub> ) <sub>1.0784314</sub> rgBT <sub>4</sub> Overlcock	0.7	4
50	Impedance Spectroscopy of Sodium Excess Ta-Modified (K <sub>0.5</sub> Na <sub>0.5</sub> )NbO <sub>3</sub> Ceramics Prepared by Reactive Tempered Grain Growth. <i>Ferroelectrics</i> , 2014, 464, 107-115.	0.6	4
51	Electrical Properties of V-Doped Na <sub>0.5</sub> Bi <sub>4.5</sub> Ti <sub>4</sub> O <sub>15</sub> Thin Films Prepared by Chemical Solution Deposition. <i>Ferroelectrics</i> , 2010, 406, 39-43.	0.6	3
52	Reduced leakage current and improved ferroelectric properties of Eu and Mn codoped BiFeO <sub>3</sub> thin films. <i>Journal of the Korean Physical Society</i> , 2012, 60, 203-206.	0.7	3
53	Effects of transition metal (Ni, Mn, Cu) doping on ferroelectric properties of Bi <sub>0.9</sub> Nd <sub>0.1</sub> FeO <sub>3</sub> thin films prepared by chemical solution deposition method. <i>Journal of Electroceramics</i> , 2013, 30, 55-59.	2.0	3
54	The Effects of Mn Substitution and Oxidation States of Mn in BiFeO <sub>3</sub> Thin Films. <i>Ferroelectrics</i> , 2013, 454, 57-62.	0.6	3

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55	Synthesis, Structural Analysis, and Dielectric Response of NaNbO <sub>3</sub> Particles Synthesized by Different Techniques. Materials and Manufacturing Processes, 2014, 29, 733-737.	4.7	3
56	Structural, electrical, and multiferroic properties of Aurivillius Bi <sub>6</sub> Fe <sub>2</sub> (Ti <sub>3-x</sub> V <sub>x</sub> )O <sub>18+̑</sub> thin films prepared by chemical solution deposition. Journal of Electroceramics, 2016, 36, 76-81.	2.0	3
57	Retention Characteristics of Bi 3.25 La 0.75 Ti 3 O 12 Films Deposited by Using Pulsed Laser Deposition. Ferroelectrics, 2002, 271, 63-68.	0.6	2
58	The C-V Characteristics of Metal/Bi <sub>3.54</sub> Nd <sub>0.46</sub> Ti <sub>3</sub> O <sub>12</sub> /Silicon Structure. Ferroelectrics, 2005, 328, 133-137.	0.6	2
59	Effects of A-Site Ionic Contents on Piezoelectric and Ferroelectric Properties of Lead-Free (K <sub>0.5</sub> Na <sub>0.5</sub> )NbO <sub>3</sub> -LiNbO <sub>3</sub> Ceramics. Ferroelectrics, 2009, 381, 176-182.	0.6	2
60	Energy Band Gap Shift of ZnS-ZnO Thin Films Grown by Pulsed Laser Deposition. Ferroelectrics, 2010, 404, 186-191.	0.6	2
61	Effects of Annealing Atmosphere on Structure and Electrical Properties of (Bi <sub>0.9</sub> Eu <sub>0.1</sub> )(Fe <sub>0.9</sub> Mn <sub>0.1</sub> )O <sub>3</sub> Thin Films. Integrated Ferroelectrics, 2012, 132, 39-44.	0.7	2
62	Electric properties of a textured BiNaKTiO <sub>3</sub> ceramic for energy harvesting system. Journal of the Korean Physical Society, 2012, 60, 240-243.	0.7	2
63	A rhombohedral structure-properties relation in Pb-free Bi <sub>0.5</sub> (Na <sub>1-x</sub> K <sub>x</sub> ) <sub>0.5</sub> TiO <sub>3</sub> ceramics. Journal of the Korean Physical Society, 2012, 60, 284-287.	0.7	2
64	Leakage Current Behaviors of SrTiO <sub>3</sub> Capped Mn-doped Polycrystalline BiFeO <sub>3</sub> Thin Film. Ferroelectrics, 2013, 454, 19-22.	0.6	2
65	Effects of Mn-doping on the electrical and the ferroelectric properties of Bi <sub>6</sub> Fe <sub>2</sub> Ti <sub>3</sub> O <sub>18</sub> thin films prepared by using chemical solution deposition. Journal of the Korean Physical Society, 2015, 66, 1344-1349.	0.7	2
66	Enhancement of Dielectric and Piezoelectric Properties of with Na/K Ion Excess in A-site. Ferroelectrics, 2015, 479, 22-28.	0.6	2
67	AC Conductivity and Dielectric Relaxation of Ion Doped Ferroelectric SrBi <sub>2</sub> Nb <sub>2</sub> O <sub>9</sub> Ceramics. Ferroelectrics, 2002, 268, 345-350.	0.6	1
68	The Lanthanide Doping Effects on the Electrical Properties of Bi <sub>4</sub> Ti <sub>3</sub> O <sub>12</sub> Thin Films Fabricated on Silicon Substrates. Integrated Ferroelectrics, 2004, 65, 49-55.	0.7	1
69	FERROELECTRIC SWITCHING DYNAMICS AND PULSE-SWITCHING POLARIZATION MEASUREMENTS. Integrated Ferroelectrics, 2005, 73, 115-121.	0.7	1
70	Enhancement of Ferroelectricity in Rare Earth and Manganese Ions Co-doped BiFeO <sub>3</sub> Thin Films via Chemical Solution Deposition Method. Integrated Ferroelectrics, 2012, 132, 45-52.	0.7	1
71	Electrical Properties of (Bi <sub>0.9</sub> Ho <sub>0.1</sub> )(Fe <sub>0.975</sub> Cr <sub>0.025</sub> )O <sub>3</sub> Thin Films Prepared by Using a Chemical Solution Deposition. Integrated Ferroelectrics, 2012, 140, 49-55.	0.7	1
72	Thickness-dependent ferroelectric behaviors of (111)-textured polycrystalline pseudo-cubic BiFeO <sub>3</sub> thin films. Journal of the Korean Physical Society, 2012, 60, 288-291.	0.7	1

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73	A-site effects on the dielectric and the piezoelectric properties of $(Na_{0.50+x}K_{0.50-x})(Nb_{0.55}Ta_{0.45})O_3$ ceramics. Journal of the Korean Physical Society, 2012, 60, 297-300.	0.7	1
74	Temperature dependence of the electrical properties in MnO-modified BiFeO <sub>3</sub> thin films. Journal of the Korean Physical Society, 2013, 62, 1073-1076.	0.7	1
75	Circuit Parameter Effects in Pulse Switching Responses of Ferroelectric Capacitors. Ferroelectrics, 2002, 273, 107-112.	0.6	0
76	Ferroelectric Properties of (Bi, Sm)4Ti3O <sub>12</sub> (BST) Thin Films Fabricated by a Metalorganic Solution Deposition Method. Journal of Electroceramics, 2004, 13, 83-88.	2.0	0
77	Charge Retention Loss and Its Mechanism of (Bi, La)4Ti3O <sub>12</sub> Capacitors. Integrated Ferroelectrics, 2004, 67, 85-91.	0.7	0
78	Microstructure and Ferroelectric Properties of (Bi,Nd)4Ti3O <sub>12</sub> Thin Films Fabricated by a Sol-Gel Process. Ferroelectrics, 2005, 328, 139-143.	0.6	0
79	Orientation Dependence of Electrical Properties of Bi <sub>3.15</sub> Pr <sub>0.85</sub> Ti <sub>3</sub> O <sub>12</sub> Thin Films. Ferroelectrics, 2010, 406, 44-48.	0.6	0
80	Piezoelectric and Dielectric Properties of (Bi <sub>0.5</sub> K <sub>0.5+x</sub> ) <sub>y</sub> TiO <sub>3</sub> Ceramics. Ferroelectrics, 2010, 404, 82-87.	0.6	0
81	Structure and Electrical Properties of Rare Earth Substituted Bi(Fe <sub>0.975</sub> Cu <sub>0.025</sub> )O <sub>3-δ</sub> Thin Films Prepared by Chemical Solution Deposition. Integrated Ferroelectrics, 2012, 132, 22-29.	0.7	0
82	Effects of Li Substitution in $(Na_{0.53}K_{0.47-x}Li_x)NbO_3$ Ceramics. Integrated Ferroelectrics, 2012, 133, 61-66.	0.7	0
83	Structural and Electrical Studies on (Nd, V) Co-doped (Bi <sub>0.9</sub> Nd <sub>0.1</sub> )(Fe <sub>0.975</sub> V <sub>0.025</sub> )O <sub>3+δ</sub> Thin Films. Integrated Ferroelectrics, 2012, 140, 56-63.	0.7	0
84	A Phenomenological Approach to Phase Transition Temperatures of Pb(Zr,Ti)O <sub>3</sub> -BiFeO <sub>3</sub> System. Ferroelectrics, 2013, 450, 16-20.	0.6	0
85	Effect of A-site Excess on the Piezoelectric Properties of $(K_{0.48}Na_{0.52})_{1+x}(Nb_{0.55}Ta_{0.45})O_{36}Tb$ Films. Ferroelectrics, 2014, 465, 60-67.		